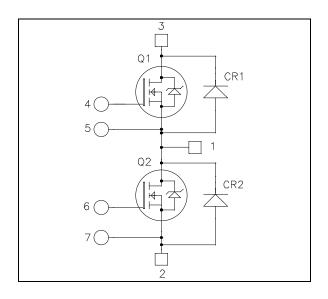
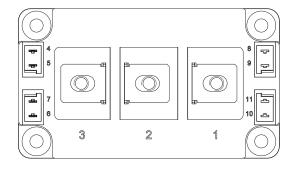
## Phase leg SiC Power Module





 $V_{DSS} = 1200V$   $R_{DSon} = 12.5 m\Omega$  typ @  $Tj = 25^{\circ}C$  $I_D = 171A$  @  $Tc = 25^{\circ}C$ 

#### **Application**

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- EV motor and traction drive

#### **Features**

- SiC Power MOSFET
  - Low  $R_{DS(on)}$
  - High temperature performance

#### • SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- High level of integration
- AlN substrate for improved thermal performance
- M6 power connectors

### **Benefits**

- High efficiency converter
- Stable temperature behavior
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- RoHS Compliant

### All ratings (a) $T_j = 25$ °C unless otherwise specified

### Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{DSS}$	Drain - Source Voltage		1200	V
T_	Continuous Drain Current	$T_c = 25$ °C	171	
$I_D$	Continuous Drain Current	$T_c = 80^{\circ}C$	136	Α
$I_{DM}$	Pulsed Drain current	342		
$V_{GS}$	Gate - Source Voltage	-10/25	V	
$R_{DSon}$	Drain - Source ON Resistance	15.5	mΩ	
$P_{\mathrm{D}}$	Power Dissipation	$T_c = 25^{\circ}C$	728	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



## **Electrical Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V ; V_{DS} = 1200V$			20	200	μΑ
D	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25$ °C		12.5	16	
R <sub>DS(on)</sub>		$I_D = 80A$	$T_j = 175$ °C		20		mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 2mA$		1.8	2.8		V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				200	nA

## **Dynamic Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Test Conditions		Тур	Max	Unit
Ciss	Input Capacitance	$ V_{GS} = 0V $ $V_{DS} = 1000V $			6040		
$C_{oss}$	Output Capacitance				540		pF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz			50		
$Q_{g}$	Total gate Charge	$V_{GS}$ = -5/20V $V_{Bus}$ = 800V $I_{D}$ = 80A			464		
$Q_{gs}$	Gate – Source Charge				82		пC
$Q_{\mathrm{gd}}$	Gate – Drain Charge				100		
T <sub>d(on)</sub>	Turn-on Delay Time	$\begin{aligned} &V_{GS} = -5/20 V \; ; \; V_{Bus} = 600 V \\ &I_D = 100 A \; ; \; T_J = 150 ^{\circ} C \\ &R_{GON} = 4 \Omega \; ; \; R_{GOFF} = 2.4 \Omega \end{aligned}$			60		
$T_r$	Rise Time				50		ns
$T_{d(off)}$	Turn-off Delay Time				180		
$T_{\mathrm{f}}$	Fall Time				30		
E <sub>on</sub>	Turn on Energy	Inductive Switching V <sub>GS</sub> = -5/+20V	$T_j = 150$ °C		2.04		mJ
$E_{ m off}$	Turn off Energy	$V_{Bus} = 600V; I_D = 100A$ $R_{GON} = 4\Omega; R_{GOFF} = 2.4\Omega$	$T_j = 150$ °C		1.8		mJ
$R_{Gint}$	Internal gate resistance			2.94		Ω	
$R_{thJC}$	Junction to Case Thermal Resistance					0.206	°C/W

## **Body diode ratings and characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
17	Diode Forward Voltage	$V_{GS} = 0V ; I_{SD} = 80A$		4		17
$ m V_{SD}$		$V_{GS} = -5V ; I_{SD} = 80A$		4.2		V
$t_{rr}$	Reverse Recovery Time	$I_{SD} = 80 A \; ; \; V_{GS} = -5 V \\ V_R = 800 V \; ; \; di_F/dt = 2000 A/\mu s \; - 100 M_{\odot}$		90		ns
Qrr	Reverse Recovery Charge			1100		nC
$I_{rr}$	Reverse Recovery Current			27		A



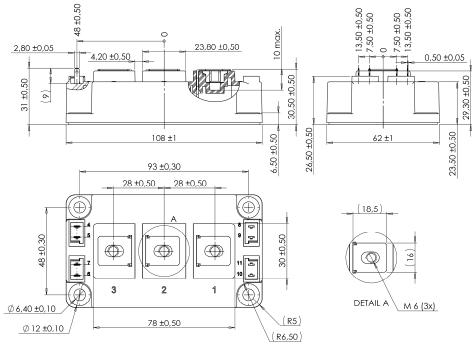
### SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit	
$V_{RRM}$	Peak Repetitive Reverse Voltage					1200	V	
$I_{RRM}$	Reverse Leakage Current	V <sub>R</sub> =1200V	$T_j = 25^{\circ}C$		20	400	μA	
	•		$T_{\rm j} = 175^{\circ}{\rm C}$		300		•	
$I_{\mathrm{F}}$	Forward Current		Tc = 100°C		60		Α	
$V_{-}$	$V_F$ Diode Forward Voltage $I_F = 60A$	$T_j = 25$ °C		1.5	1.8	V		
V F		I <sub>F</sub> = 00A	$T_j = 175$ °C		2.1		V	
Qc	Total Capacitive Charge	$V_R = 600V$	$V_R = 600V$		260		nC	
C	Total Canacitance	C Total Capacitance –	$f = 1 \text{MHz}, V_R = 400 \text{V}$			282		рF
	f = 1MHz, V		= 800V		210		PΙ	
$R_{\text{thJC}}$	Junction to Case Thermal Resistance					0.49	°C/W	

## Thermal and package characteristics

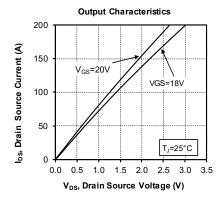
Symbol	Characteristic			Min	Max	Unit
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz			4000		V
$T_{\rm J}$	Operating junction temperature range			-40	175	
$T_{\text{JOP}}$	Recommended junction temperature und	ler switching condi	itions	-40	T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range			-40	125	
$T_{\rm C}$	Operating Case Temperature				125	
Томаца	Mayating tangua	For terminals	M6	3	5	N.m
Torque	Mounting torque To Heatsink M6		M6	3	5	IN.III
Wt	Package Weight				350	g

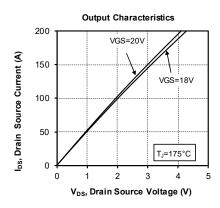
### Package outline (dimensions in mm)

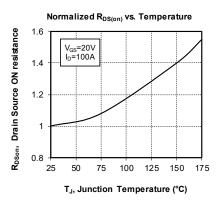


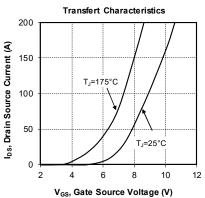
See application note 1908 - Mounting instructions for D3 & D4 power modules

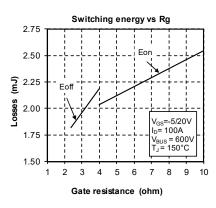
### **Typical SiC MOSFET Performance Curve**

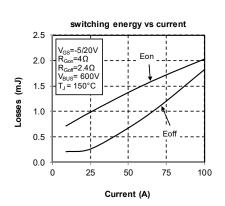




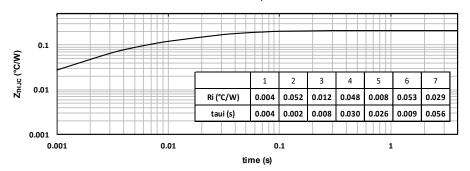


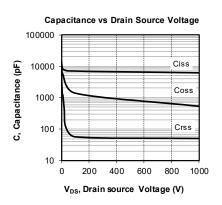


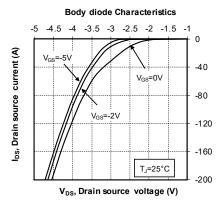


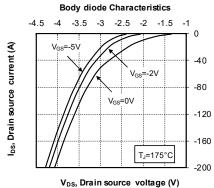


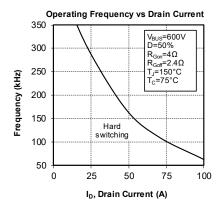
#### Maximum thermal impedance

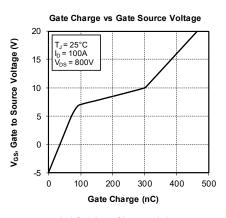


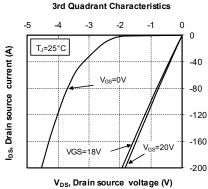


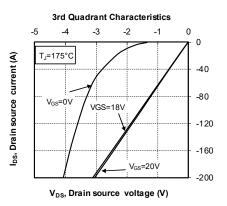








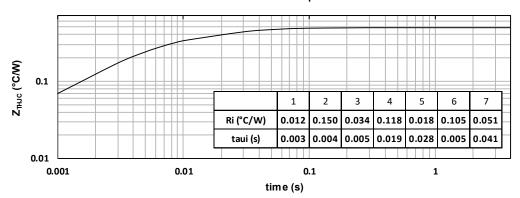


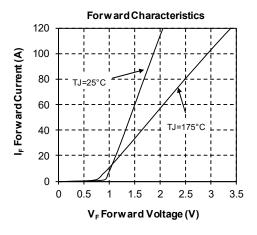


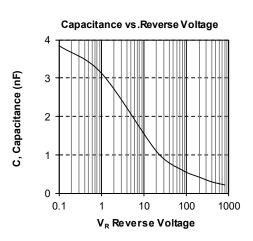


## Typical SiC diode Performance Curve

#### ${\bf Maxim\,um\,thermal\,impedance}$









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